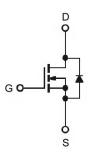


N-Channel 650-V (D-S) MOSFET

Description

The device is using advanced Super-Junction technology. This advanced technology has been especially tailored to minimize conduction loss, provide superior switching performance and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for AC/DC power conversion in switching mode operation for higher efficiency.



Graphic Symbol

Package Dimension

Features

- 20A, 650V, R_{DS(ON)typ} =0.20Ω@ V_{GS} =10V
- Low Gate Charge (typical 38nC)
- High Ruggedness
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability

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Typical Applications

- Switching Mode Power Supply
- Adapter / Charger
- Server Power

REF	Millimeter		REF.	Millimeter		
	Min.	Max.	NEF.	Min.	Max.	
Α	4.30	4.70	D2	15.70	17.00	
A1	1.20	1.40	E	9.70	10.36	
A2	2.30	2.79	е	2.54 BSC		
b	0.70	0.90	H1	6.10	6.70	
b1	1.20	1.75	L	12.80	13.90	
С	0.34	0.60	L1	-	4.00	
D	14.70	16.10	Q	2.60	3.00	
D1	8.60	9.30	Ø	3.55	3.95	

Package type : TO-220







N-Channel 650-V (D-S) MOSFET

MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
Vds	Drain-Source Voltage	650	V		
V _{GS}	Gate-Source Voltage	±30	V		
1-	Continuous Drain Current ¹ (T _c =25°C)	20	А		
lp	Continuous Drain Current ¹ (T _c =100°C)	12	А		
IDM	Pulsed Drain Current ^{1,2}	80	А		
las	Single Pulse Avalanche Current, L =79mH ³	4.2	А		
Eas	Single Pulse Avalanche Energy, L =79mH ³	697	mJ		
dv/dt	Peak Diode Recovery dv/dt	15	V/ns		
D	Power Dissipation ⁴ (T _C =25°C)	227	W		
PD	Derating Factor Above 25°C	1.8	W/°C		
TJ/Tstg	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62.5	°C/W		
Rejc	Maximum Junction-to-Case ¹	0.55	°C/W		

Electrical Characteristics (TJ=25°C unless otherwise specified)						
Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250µA	2.0	-	4.0	V
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250µA	650	-	-	V
$BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	I_D = 250µA, referenced to 25°C	-	0.69	-	V/°C
I _{GSS}	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 30V$	-	-	±100	nA
IDSS	Drain-Source Leakage Current	V _{DS} =650V, V _{GS} =0V, T _C =25°C V _{DS} =520V, V _{GS} =0V, T _C =125°C	-	-	1 10	μA
RDS (on)	Static Drain-Source On-Resistance	V_{GS} =10V, I _D =10A	-	0.2	0.24	Ω
Rg	Gate Resistance	V_{GS} = V_{DS} =0V, f =1.0MHz	-	2.2	-	Ω



N-Channel 650-V (D-S) MOSFET

Dynamic	;					
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =520V		38		
Qgs	Gate-Source Charge	I _D =20A		9.0		nC
Qgd	Gate-Drain Charge	V _{GS} =10V		20		
td(on)	Turn-On Delay Time ²	V _{DS} =325V		20		
tr	Rise Time	I _D =20A		56		
td(off)	Turn-Off Delay Time	V _{GS} =10V		106		ns
tf	Fall Time	R _G =25Ω		41		
Ciss	Input Capacitance	V _{DS} =100V		1197		
Coss	Output Capacitance	V _{GS} =0V		67		pF
CRSS	Reverse Transfer Capacitance	f =1.0MHz		3.7		

Source-Drain Diode						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Is	Continuous Source Current ^{1,5}		-	-	20	
Ism	Pulsed Source Current ^{2,5}	$V_{\rm G}$ = $V_{\rm D}$ = 0V, Force Current	-	-	80	A
V _{SD}	Diode Forward Voltage ²	Is =20A, V _{GS} =0V, T _J =25°C	-	-	1.4	V
t _{rr}	Reverse Recovery Time ²	I _S =20A, V _{GS} =0V, dI _F / dt =		420		ns
Qrr	Reverse Recovery Charge ²	100A/µs		6.1		μC

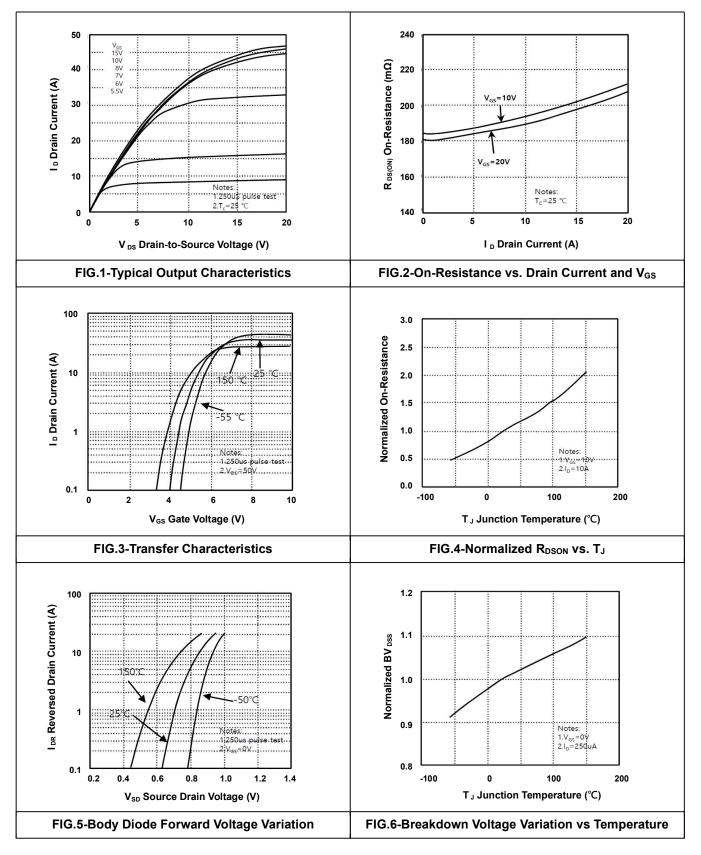
Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =100V, L=79mH, I_{AS}=4.2A.
- 4. The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature.
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



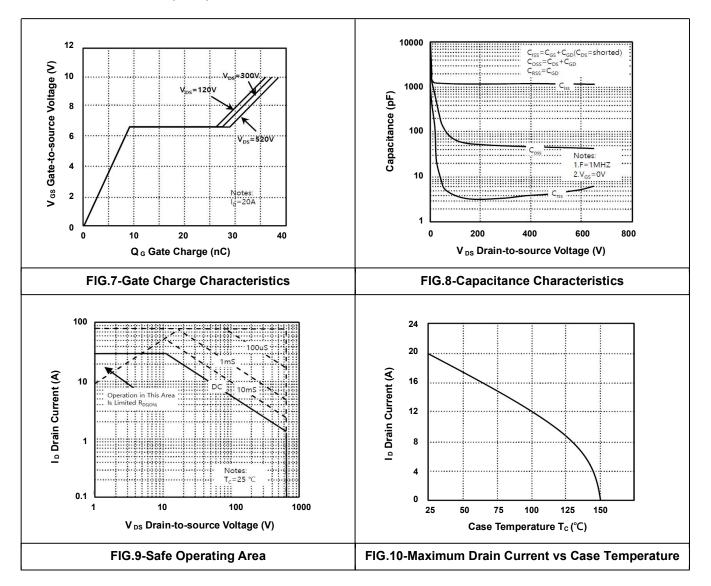
N-Channel 650-V (D-S) MOSFET

• Typical Electrical Characteristics





N-Channel 650-V (D-S) MOSFET





N-Channel 650-V (D-S) MOSFET

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